



FQD5N15 / FQU5N15

150V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifire, high efficiency switching for DC/DC converters, and DC motor control, uninterrupted power supply.

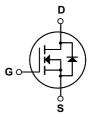
Features

- 4.3A, 150V, $R_{DS(on)} = 0.8\Omega @V_{GS} = 10 V$
- Low gate charge (typical 5.4 nC)
- Low Crss (typical 7.5 pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter		FQD5N15 / FQU5N15	Units	
V _{DSS}	Drain-Source Voltage		150	V	
I _D	Drain Current - Continuous (T _C = 25°C)		4.3	Α	
	- Continuous (T _C = 100°C)		2.72	Α	
I _{DM}	Drain Current - Pulsed	(Note 1)	17.2	Α	
V _{GSS}	Gate-Source Voltage		± 25	V	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	55	mJ	
I _{AR}	Avalanche Current	(Note 1)	4.3	А	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	3.0	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns	
P _D	Power Dissipation (T _A = 25°C) *		2.5	W	
	Power Dissipation (T _C = 25°C)		30	W	
	- Derate above 25°C		0.24	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		4.17	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$ Thermal Resistance, Junction-to-Ambient			110	°C/W

* When mounted on the minimum pad size recommended (PCB Mount)

Rev. A1, October 2008

Symbol	Parameter	Test Conditions	i	Min	Тур	Max	Units
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		150			V
ΔBV_{DSS} / ΔT_{J}	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C			0.17		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 150 V, V _{GS} = 0 V				1	μА
		V _{DS} = 120 V, T _C = 125°C	;			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 25 V, V _{DS} = 0 V				100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -25 V, V _{DS} = 0 V				-100	nA
On Cha	racteristics						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 2.15 A			0.62	0.8	Ω
g _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 2.15 A	(Note 4)		2.53		S
Dynami	ic Characteristics						
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			175	230	pF
C _{oss}	Output Capacitance				40	50	pF
C _{rss}	Reverse Transfer Capacitance				7.5	10	pF
Switchi	ng Characteristics						
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 75 \text{ V}, I_{D} = 5.4 \text{ A},$ $R_{G} = 25 \Omega$			5	20	ns
t _r	Turn-On Rise Time				45	100	ns
t _{d(off)}	Turn-Off Delay Time	11G - 25 12			13	35	ns
t _f	Turn-Off Fall Time		(Note 4, 5)		25	60	ns
Qg	Total Gate Charge	V _{DS} = 120 V, I _D = 5.4 A,			5.4	7.0	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V			1.4		nC
Q _{gd}	Gate-Drain Charge		(Note 4, 5)		2.5		nC
Drain C	Course Diede Characteristics of	ad Maximum Dating	_				
I _S	Source Diode Characteristics at Maximum Continuous Drain-Source Did		5			4.3	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				17.2	A	
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 4.3 A				1.5	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_S = 5.4 \text{ A,}$			70		ns
Q _{rr}	Reverse Recovery Charge	dl _F / dt = 100 A/μs	(Note 4)		0.17		μС

- Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 4.96mH, I_{AS} = 4.3A, V_{DD} = 25V, R_G = 25 Ω , Starting T_J = 25°C 3. I_{SD} ≤ 5.4A, didt ≤ 300A/us, V_{DD} ≤ BVDss, Starting T_J = 25°C 4. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

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Typical Characteristics

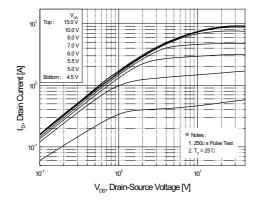


Figure 1. On-Region Characteristics

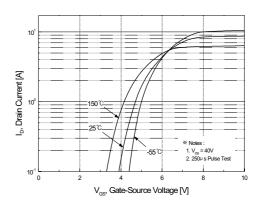


Figure 2. Transfer Characteristics

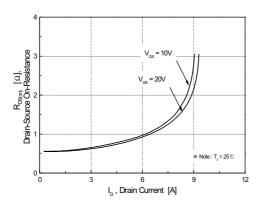


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

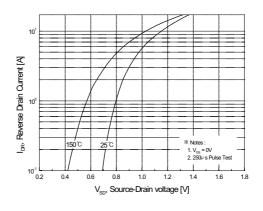


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

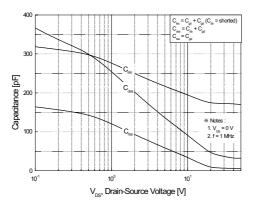


Figure 5. Capacitance Characteristics

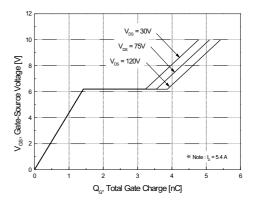
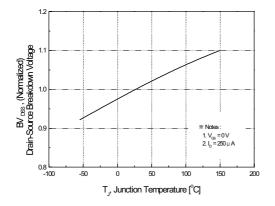


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)



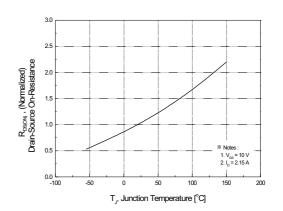
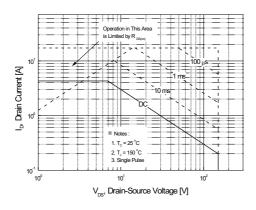


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



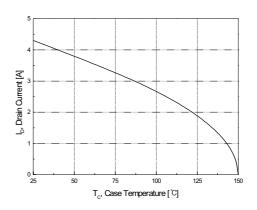


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

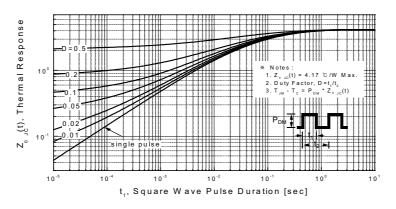
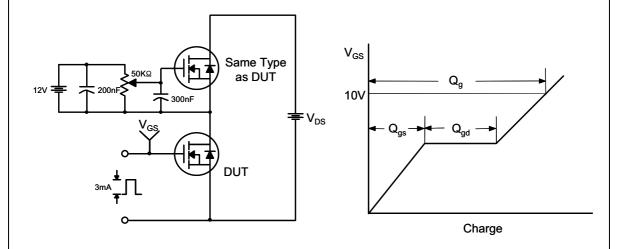
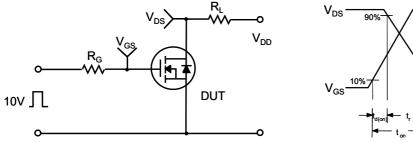


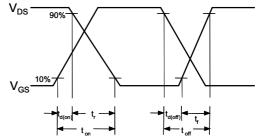
Figure 11. Transient Thermal Response Curve

Gate Charge Test Circuit & Waveform

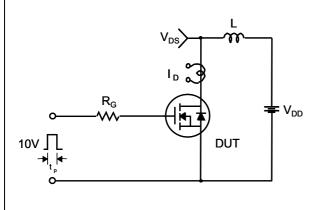


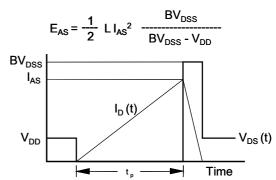
Resistive Switching Test Circuit & Waveforms



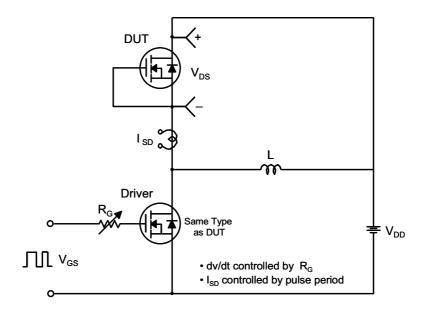


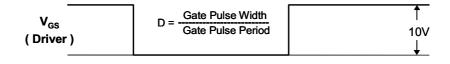
Unclamped Inductive Switching Test Circuit & Waveforms

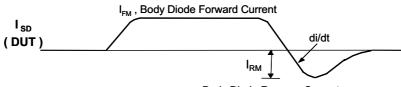




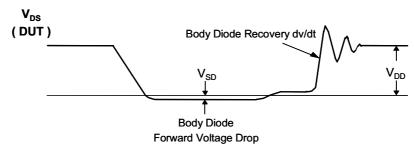
Peak Diode Recovery dv/dt Test Circuit & Waveforms



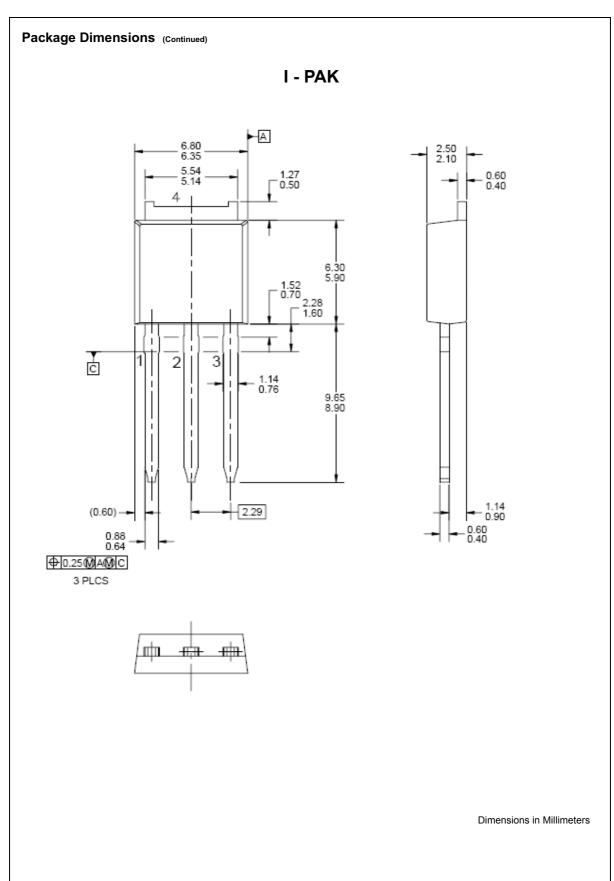




Body Diode Reverse Current



Package Dimensions D - PAK -6.00 MIN-6.50 MIN C (0.59) 1.40 MIN → 2.29 - 4.60 - Ф 0.25M AM C 4.57 LAND PATTERN RECOMMENDATION SEE NOTE D _ 0.58 0.46 10.41 9.40 SEE DETAIL A △ 0.10 B 0.51 GAGE PLANE 0.127 MAX-SEATING PLANE - (2.90) Dimensions in Millimeters







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